



<p>Searched</p> 	<p>Application/Control No.</p> <p>10028825</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>YAMASAKI ET AL.</p>
	<p>Examiner</p> <p>Tran, Mai T</p>	<p>Art Unit</p> <p>2129</p>


Class	SubClass	Date	Examiner
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Search Notes 	Application/Control No. 10028825	Applicant(s)/Patent Under Reexamination YAMASAKI ET AL.
	Examiner Trañ, Mai T	Art Unit 2129

Notes	Date	Examiner
EAST (Please see search history printout)	8/16/2006	mtt
Plus Search (PLease see search results printout)	8/3/2006	mtt

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